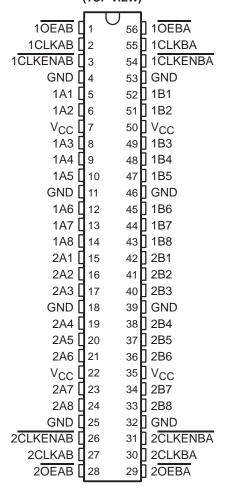
SCBS697E - JULY 1997 - REVISED APRIL 1999

- **Members of the Texas Instruments** Widebus™ Family
- State-of-the-Art Advanced BiCMOS Technology (ABT) Design for 3.3-V Operation and Low Static-Power Dissipation
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V_{CC})
- **Support Unregulated Battery Operation** Down to 2.7 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, T_A = 25°C
- I_{off} and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the **Need for External Pullup/Pulldown** Resistors
- Distributed V_{CC} and GND Pin Configuration **Minimizes High-Speed Switching Noise**
- Flow-Through Architecture Optimizes PCB Layout
- **Latch-Up Performance Exceeds 500 mA Per JESD 17**
- **ESD Protection Exceeds 2000 V Per** MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- **Package Options Include Plastic Shrink** Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package **Using 25-mil Center-to-Center Spacings**

SN54LVTH16952 . . . WD PACKAGE SN74LVTH16952 . . . DGG OR DL PACKAGE (TOP VIEW)



description

The 'LVTH16952 devices are 16-bit registered transceivers designed for low-voltage (3.3-V) V_{CC} operation, but with the capability to provide a TTL interface to a 5-V system environment.

These devices can be used as two 8-bit transceivers or one 16-bit transceiver. Data on the A or B bus is stored in the registers on the low-to-high transition of the clock (CLKAB or CLKBA) input provided that the clock-enable (CLKENAB or CLKENBA) input is low. Taking the output-enable (OEAB or OEBA) input low accesses the data on either port.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

When V_{CC} is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, $\overline{\text{OE}}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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SCBS697E - JULY 1997 - REVISED APRIL 1999

description (continued)

These devices are fully specified for hot-insertion applications using I_{off} and power-up 3-state. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

The SN54LVTH16952 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74LVTH16952 is characterized for operation from –40°C to 85°C.

FUNCTION TABLET

	OUTPUT			
CLKENAB	CLKAB	OEAB	Α	В
Н	Х	L	Χ	в ₀ ‡
Х	L	L	Χ	_{В0} ‡ _{В0} ‡
L	\uparrow	L	L	L
L	\uparrow	L	Н	Н
Х	X	Н	Χ	Z

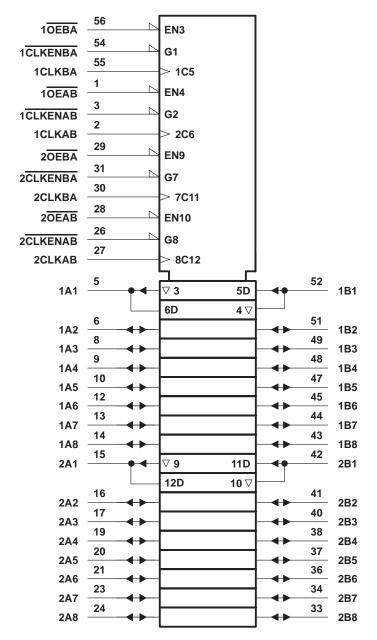
[†] A-to-B data flow is shown; B-to-A data flow is similar, but uses CLKENBA, CLKBA, and OEBA.



[‡]Level of B before the indicated steady-state input conditions were established

SCBS697E - JULY 1997 - REVISED APRIL 1999

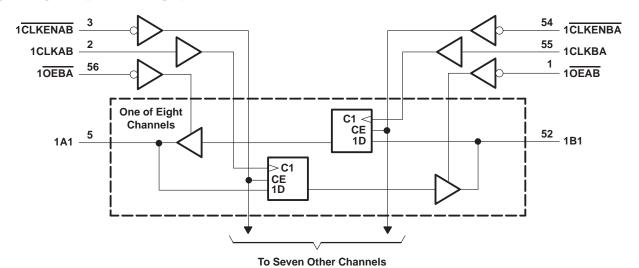
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SCBS697E - JULY 1997 - REVISED APRIL 1999

logic diagram (positive logic)



31 2CLKENBA 26 2CLKENAB 30 2CLKBA 27 2CLKAB 28 2OEAB 29 2<mark>OEBA</mark> One of Eight C1 < Channels CE 42 2B1 15 2A1 -1D > **C**1

To Seven Other Channels

SCBS697E - JULY 1997 - REVISED APRIL 1999

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC} –0.5	V to 4.6 V
Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high-impedance	
or power-off state, V _O (see Note 1)	.5 V to 7 V
Voltage range applied to any output in the high state, V _O (see Note 1)0.5 V to V _O	_{CC} + 0.5 V
Current into any output in the low state, IO: SN54LVTH16952	96 mA
SN74LVTH16952	. 128 mA
Current into any output in the high state, IO (see Note 2): SN54LVTH16952	48 mA
SN74LVTH16952	64 mA
Input clamp current, I _{IK} (V _I < 0)	. –50 mA
Output clamp current, I _{OK} (V _O < 0)	. –50 mA
Package thermal impedance, θ _{JA} (see Note 3): DGG package	. 81°C/W
DL package	. 74°C/W
Storage temperature range, T _{stq} 65°C	C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
 - 2. This current flows only when the output is in the high state and $V_O > V_{CC}$.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

		SN54LVTI	H16952	SN74LVTI	UNIT		
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	2.7	3.6	2.7	3.6	V	
VIH	High-level input voltage		2		2		V
V _{IL}	Low-level input voltage		0.8		0.8	V	
VI	Input voltage		5.5		5.5	V	
ІОН	High-level output current		-24		-32	mA	
loL	Low-level output current			48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
Δt/ΔV _{CC}	Power-up ramp rate		200		200		μs/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



SCBS697E - JULY 1997 - REVISED APRIL 1999

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			4LVTH16	6952	SN7	4LVTH16	6952	UNIT			
PAR	KAWETER	1531 CC	UNDITIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNII			
VIK		$V_{CC} = 2.7 \text{ V},$	I _I = -18 mA			-1.2			-1.2	V			
Voн		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V},$	I _{OH} = -100 μA	V _{CC} -0	.2		V _{CC} -0	.2					
		$V_{CC} = 2.7 \text{ V},$	I _{OH} = -8 mA	2.4			2.4			V			
		V _{CC} = 3 V	$I_{OH} = -24 \text{ mA}$	2						V			
		VCC = 3 V	$I_{OH} = -32 \text{ mA}$				2						
		V _{CC} = 2.7 V	I _{OL} = 100 μA			0.2			0.2				
		VCC = 2.7 V	I _{OL} = 24 mA			0.5			0.5				
VOL			I _{OL} = 16 mA			0.4			0.4	V			
VOL		V _{CC} = 3 V	I _{OL} = 32 mA			0.5			0.5	·			
		VCC = 3 V	I _{OL} = 48 mA			0.55							
			$I_{OL} = 64 \text{ mA}$						0.55	1 1			
	Control inputs	$V_{CC} = 3.6 \text{ V},$	V _I = V _{CC} or GND						±1				
	Control inputs	$V_{CC} = 0 \text{ or } 3.6 \text{ V},$	V _I = 5.5 V			10			10				
I _I A	A or B ports‡	V _{CC} = 3.6 V	V _I = 5.5 V			20			20	μΑ			
			$V_I = V_{CC}$		1			1					
			V _I = 0			-5			- 5				
l _{off}		$V_{CC} = 0$,	V_I or $V_O = 0$ to 4.5 V						±100	μΑ			
		V _{CC} = 3 V	V _I = 0.8 V	75 75 -75 -75									
II(hold)	A or B ports	VCC = 3 V	V _I = 2 V			– 75		μΑ					
		V _{CC} = 3.6 V§,	$V_{I} = 0 \text{ to } 3.6 \text{ V}$						±500				
lozpu		$\frac{V_{CC}}{OE} = 0$ to 1.5 V, $V_{O} = \frac{V_{CC}}{OE} = 0$ don't care	0.5 V to 3 V,			±100*			±100	μΑ			
lozpd		$\frac{\text{V}_{\text{CC}}}{\text{OE}} = 1.5 \text{ V to 0, V}_{\text{O}} = \frac{\text{V}_{\text{CC}}}{\text{OE}} = \text{don't care}$	0.5 V to 3 V,			±100*			±100	μΑ			
		V _{CC} = 3.6 V,	Outputs high			0.19			0.19				
Icc	$I_{O} = 0$,	Outputs low		5		5			mA				
		$V_I = V_{CC}$ or GND	Outputs disabled			0.19			0.19				
		V _{CC} = 3 V to 3.6 V, One Other inputs at V _{CC} or 0				0.2			0.2	mA			
Ci		V _I = 3 V or 0			4			4		pF			
C _{io}		V _O = 3 V or 0			10			10		pF			

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



 $^{^{\}dagger}$ All typical values are at VCC = 3.3 V, TA = 25°C. ‡ Unused pins at VCC or GND

[§] This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

[¶] This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

SCBS697E - JULY 1997 - REVISED APRIL 1999

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		SN54LVTH16952				SN74LVTH16952					
			V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
fclock	Clock frequency			150		150		150		150	MHz
t _W	Pulse duration	CLK high or low	3.3		3.3		3.3		3.3		ns
	Catum times	A or B before CLK	1.9		2.5		1.7		2.5		
^t su	t _{Su} Setup time	CLKEN before CLK	2		2.8		2		2.8		ns
t _h Hold time	Hold time	A or B after CLK	0.8		0.7		0.8		0		ns
	i ioiu tiirie	CLKEN after CLK	0.4		0.4		0.4		0		115

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

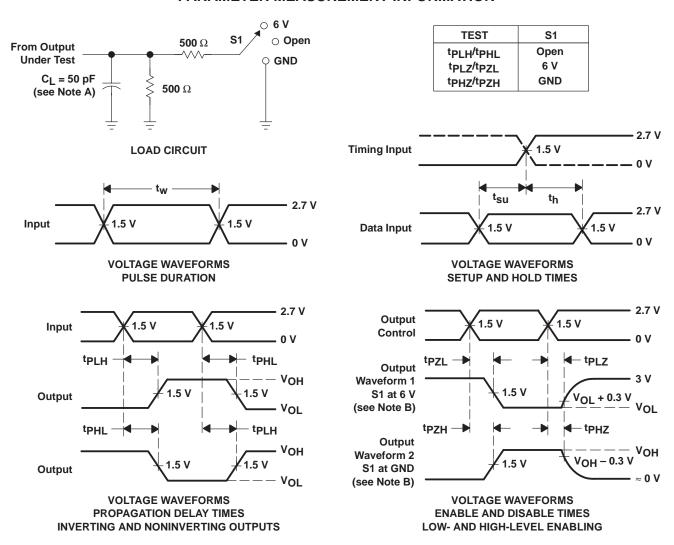
		TO (OUTPUT)	SN54LVTH16952				SN74LVTH16952					
PARAMETER	FROM (INPUT)		V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V			V _{CC} = 2.7 V		UNIT
			MIN	MAX	MIN	MAX	MIN	TYP	MAX	MIN	MAX	
f _{max}			150		150		150			150		MHz
t _{PLH}	CLKBA or CLKAB	A or B	1.3	4.6		5.1	1.3	2.7	4		4.4	ns
t _{PHL}		AOID	1.3	4.6		4.7	1.3	2.7	4		4.4	115
^t PZH	<u> </u>	A or B	1	4.3		5.1	1	2.3	4		4.9	ns
t _{PZL}	OEBA or OEAB	AOIB	1.2	4.2		5.1	1	2.4	4		4.9	115
^t PHZ	<u> </u>	A or B	1.8	6.2		6.5	2.1	3.9	5.7		6.2	ns
^t PLZ	OEBA or OEAB	AUIB	1.6	5.4		5.6	2.1	3.5	5.1		5.3	115

[†] All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



SCBS697E - JULY 1997 - REVISED APRIL 1999

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z $_{O}$ = 50 Ω , t_{f} \leq 2.5 ns, t_{f} \leq 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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